Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,608	LEE ET AL.	ET AL.
Examiner	Art Unit	Unit
B. Clayton McCraw	3744	4

SEARCHED					
Class	Subclass	Date	Examiner		
62	612, 620, 623	3/31/2006	всм		

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
Harled	3/31/2006	BCM		
		Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted with Primary Examiner, William Doerrler	3/31/2006	всм		
Consulted with Primary Examiner, Melvin Jones	3/31/2006	всм		
Conducted inventor name search	3/31/2006	всм		
EAST Search notes attached	3/31/2006	всм		
EAST Interference search attached	3/31/2006	всм		